

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10523990	HAYAISHI ET AL.
	Examiner	Art Unit
	Yang, Jie	1709

SEARCHED

Class	Subclass	Date	Examiner
420	87,88	5/11/07	JY

SEARCH NOTES

Search Notes	Date	Examiner
Combine with the search of 10/898,963	5/10/07-5/11/07	JY
Text search	5/10/07-5/11/07	JY
JP patent translation on-line	5/10/07-5/11/07	JY

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner